













ESD

103

TSS

MOV

GDT

PLED

BAT08-XXXB(MS)

Product specification





DESCRIPTION

The BAT08-XXXB(MS) SCR series with the parallel resis tor between Gate and Cathode are especially recommended for use on straight hair, igniter, anion generator, etc.

MAIN FEATURES

Symbol	Value	Unit
It(RMS)	8	А
Vdrm /Vrrm	600/800	V

Reference News

PACKAGE OUTLINE	Pin Configuration	Mark	ing		
	T2(2) G(3) T1(1)	MSKSEMI BAT08-600B MS XXX	MSKSEMI BAT08-800B MS XXX		
¹ ² ³		BTA08-600B(MS)	BTA08-800B(MS)		
	Notes :XXX represents the order code.				

ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Storage junction temperature range	Tstg	-40 - 150	°C
Operating junction temperature range	Tj	-40 - 125	°C
Repetitive peak off-state voltage (Tj=25 $^{\circ}$ C)	Vdrm	600/800	V
Repetitive peak reverse voltage (Tj=25 $^{\circ}$ C)	Vrrm	600/800	V
Non repetitive surge peak Off-state voltage	Vdsm	Vdrm +100	V
Non repetitive peak reverse voltage	Vrsm	V _{RRM} +100	V
RMS on-state Current (TC=95℃)	T(RMS)	8	А
Non repetitive surge peak on-state current (full cycle, F=50Hz)	Ітѕм	80	А
Pt value for fusing (tp=10ms)	۴t	32	A ² s
Critical rate of rise of on-state current $(I_G=2 \times I_{GT})$	dl/dt	50	A/µs
Peak gate current	Ідм	4	Α
Average gate power dissipation	P _{G(AV)}	1	W
Peak gate power	Рдм	5	W



ELECTRICAL CHARACTERISTICS (T_j=25 $^{\circ}$ C unless otherwise specified)

3 Quadrants

Symbol	Test Condition	Quadrant		Value	Unit
Ідт	· V⊳=12V R∟=33Ω	I - II-III	MAX	50	mA
Vgt	VD=12V RL=330	I - II-III	MAX	1.5	V
Vgd	Vd=Vdrm Tj=125 °C RL=3.3KΩ	I - II-III	MIN	0.2	V
	I -III		70		
L	lg=1.2Ідт	II	MAX	90	mA
lн	I⊤м=100mA		MAX	60	mA
dV/dt	V _D =2/3V _{DRM} Gate Open Tj=125℃		MIN	1000	V/µs

4 Quadrants

Symbol	Test Condition	Quadrant		Value	Unit	
Ідт			I - II-III	MAX	50	mA
IGI	$V_D=12V R_L=33\Omega$	IV	IVIAA	70	IIIA	
Vgt		ALL	MAX	1.5	V	
Vgd	Vd=Vdrm Tj=125℃ R∟=3.3KΩ	ALL	MIN	0.2	V	
L.		I -III-IV	MAX	70	mA	
L.	lg=1.2Igт	II	IVIAA	90	– mA	
н	Iтм=200mA		MAX	60	mA	
dV/dt	V _D =2/3V _{DRM} Gate Open Tj=125℃		MIN	500	V/µs	

STATIC CHARACTERISTICS

Symbol	Parameter		Value(MAX)	Unit
Vтм	Iтм =11Atp=380µs	T j =25 ℃	1.5	V
DRM		T j =25 ℃	5	μA
IRRM	Vd =Vdrm Vr =Vrrm	T j =125 ℃	1	mA

THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
Rth(j-c)	junction to case(AC)	2.7	°C /W



125

FIG.1: Maximum power dissipation versus RMS

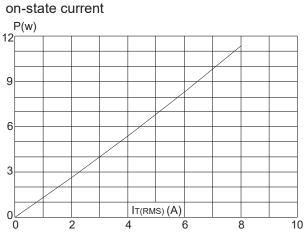


FIG.3: Surge peak on-state current versus number of cycles

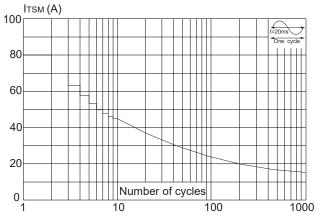
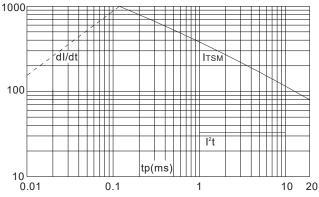
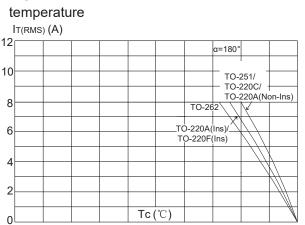
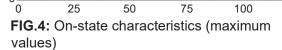


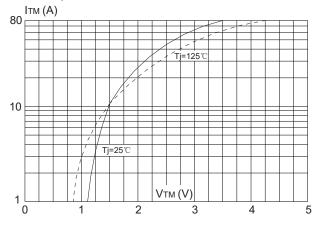
FIG.5: Non-repetitive surge peak on-state current for a sinusoidal pulse with width tp<20ms, and corresponding value of l^2t (dl/dt < 50A/µs)

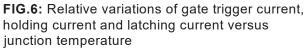
Iтѕм (A), I²t (A²s)











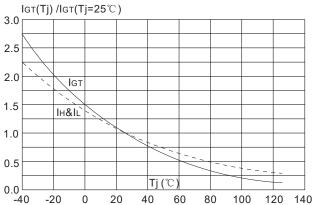
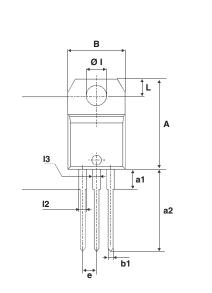
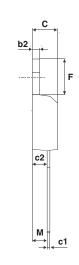


FIG.2: RMS on-state current versus case

PACKAGE MECHANICAL DATA





	DIMENSIONS					
REF.	Millimete		rs		Inches	
	Min.	Тур.	Max.	Min.	Тур.	Max.
Α	15.20		15.90	0.598		0.625
a1		3.75			0.147	
a2	13.00		14.00	0.511		0.551
В	10.00		10.40	0.393		0.409
b1	0.61		0.88	0.024		0.034
b2	1.23		1.32	0.048		0.051
С	4.40		4.60	0.173		0.181
c1	0.49		0.70	0.019		0.027
c2	2.40		2.72	0.094		0.107
е	2.40		2.70	0.094		0.106
F	6.20		6.60	0.244		0.259
ØI	3.75		3.85	0.147		0.151
14	15.80	16.40	16.80	0.622	0.646	0.661
L	2.65		2.95	0.104		0.116
12	1.14		1.70	0.044		0.066
13	1.14		1.70	0.044		0.066
М		2.60			0.102	

REEL SPECIFICATION

P/N	PKG	QTY
BAT08-XXXB(MS)	TO-220	50/One tube 1000/a box of



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